1



# N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ (m $\Omega$ )(Typ.)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)		
60	1.5 at V <sub>GS</sub> = 10 V	220	77 nC		

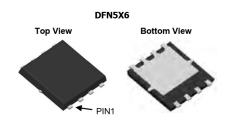
#### **FEATURES**

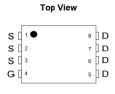
- **DT-Trench Power MOSFET**
- 100 % R<sub>g</sub> and UIS Tested

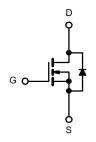


#### **APPLICATIONS**

- · Notebook PC Core
- VRM/POL







N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	60	V		
Gate-Source Voltage		V <sub>GS</sub>	± 20	¬	
	T <sub>C</sub> = 25 °C		220 <sup>a, e</sup>	A	
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>C</sub> = 70 °C		187 <sup>e</sup>		
Continuous Diam Current (1 <sub>J</sub> = 175°C)	T <sub>A</sub> = 25 °C	l <sub>D</sub> –	35 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		28 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	800		
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	195		
Single Pulse Avalanche Energy	L = 0.111111	E <sub>AS</sub>	680	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	200 <sup>a, e</sup>	A	
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	's _	4.8 b, c		
	T <sub>C</sub> = 25 °C		280 <sup>a</sup>		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	194	10/	
	T <sub>A</sub> = 25 °C	ט' [	7.8 <sup>b, c</sup>	W	
	T <sub>A</sub> = 70 °C		5.5 <sup>b, c</sup>		
Operating Junction and Storage Temperature R	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	15	19	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.41	0.54		

- Notes:
  a. Based on T<sub>C</sub> = 25 °C.
  b. Surface mounted on 1" x 1" FR4 board.
  c. t = 10 s.
  d. Maximum under steady state conditions is 90 °C/W.
  e. Calculated based on maximum junction temperature.

Rev. 1. 0

Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	60			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		36		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 <sub>D</sub> = 230 μΑ		- 5.6			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			1	μA	
0.011.0.13	<del>                                     </del>	$V_{DS} = 00 \text{ V}, V_{GS} = 0 \text{ V}, V_{J} = 33 \text{ C}$ $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	400		10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ $V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$	180	4.5	0.5	Α	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	30 5		1.5	2.5	mΩ	
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	$V_{DS} = 5 \text{ V}, I_{D} = 30 \text{ A}$		100		S	
Dynamic <sup>b</sup>				ı			
Input Capacitance	C <sub>iss</sub>			5600		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 30 V , $V_{GS}$ = 0 V, f = 1 MHz		1700			
Reverse Transfer Capacitance	C <sub>rss</sub>			210			
Total Gate Charge	Qg			77		nC	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 30 \text{ A}$		20			
Gate-Drain Charge	Q <sub>gd</sub>			14			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			21		ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 0.555\Omega$		23			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ =30 A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		36			
Fall Time	t <sub>f</sub>			8			
<b>Drain-Source Body Diode Characteristics</b>	5			1			
Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C			220		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				800	Α Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A		0.6	1.2		
V Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 30 A, di/dt = 100 A/μs, T <sub>1</sub> = 25 °C		58		ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			90		nC	
Reverse Recovery Fall Time	t <sub>a</sub>	i <sub>F</sub> = 50 A, αί/αι = 100 Αγμ5, 1 <sub>J</sub> = 25 °C		30		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			25			

#### Notes:

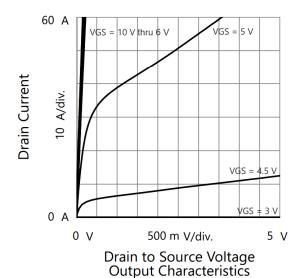
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

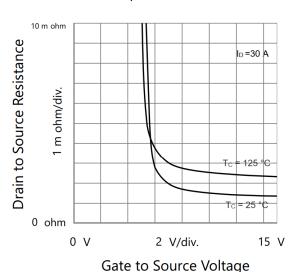
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

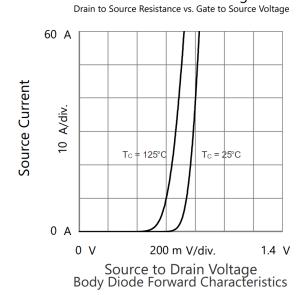
b. Guaranteed by design, not subject to production testing.

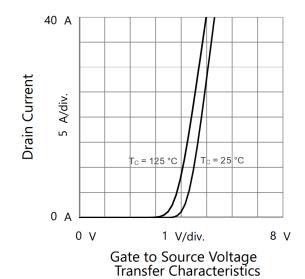
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

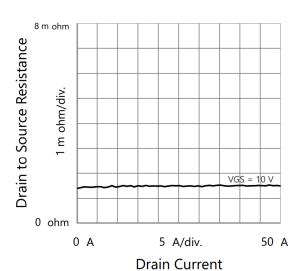
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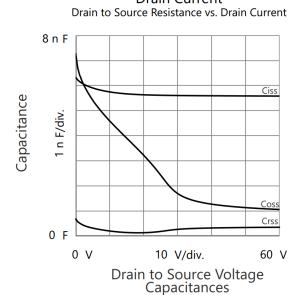






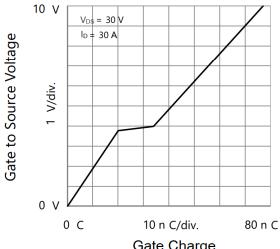






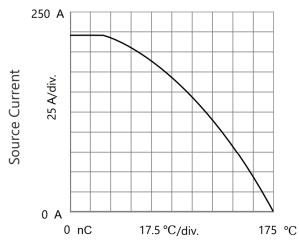
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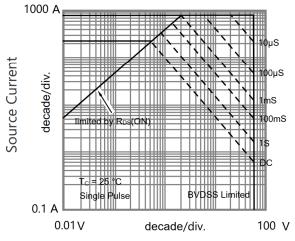


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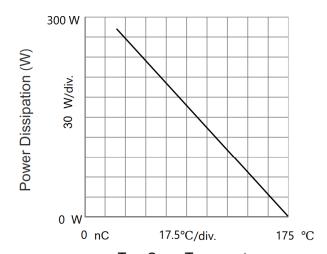
Gate Charge
Gate to Source Voltage vs. GateCharge



 $T_{C} \textbf{ - Case Temperature} \\ \text{ Current Derating}$ 

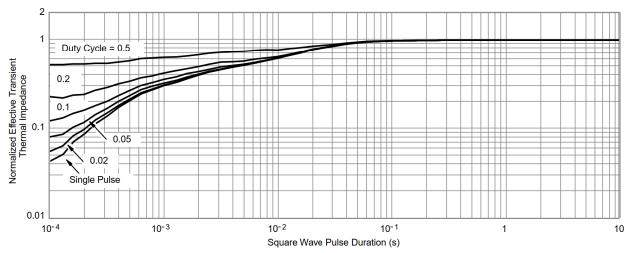


Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



T<sub>C</sub> - Case Temperature

Current Derating



Normalized Thermal Transient Impedance, Junction-to-Case



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